### **STF12N50M2**



## N-channel 500 V, 0.325 Ω typ.,10 A MDmesh II Plus™ low Q<sub>g</sub> Power MOSFET in a TO-220FP package

Datasheet - preliminary data

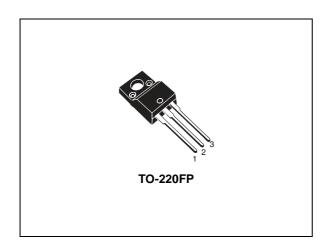
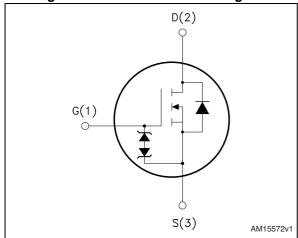


Figure 1. Internal schematic diagram



#### **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>
STF12N50M2	500 V	0.38 Ω	10 A

- Extremely low gate charge
- Lower R<sub>DS(on)</sub> x area vs previous generation
- Low gate input resistance
- 100% avalanche tested
- Zener-protected

## **Applications**

· Switching applications

#### **Description**

This device is an N-channel Power MOSFET developed using a new generation of MDmesh™ technology: MDmesh II Plus™ low Qg. This revolutionary Power MOSFET associates a vertical structure to the company's strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.

**Table 1. Device summary** 

Order code	Marking	Package	Packaging
STF12N50M2	12N50M2	TO-220FP	Tube

Contents STF12N50M2

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STF12N50M2 Electrical ratings

# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
$V_{GS}$	Gate-source voltage	± 25	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	10 <sup>(1)</sup>	Α
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	7 <sup>(1)</sup>	Α
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	40	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	85	W
dv/dt (3)	Peak diode recovery voltage slope	15	V/ns
dv/dt <sup>(4)</sup>	MOSFET dv/dt ruggedness	50	V/ns
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; T <sub>C</sub> =25 °C)		٧
T <sub>stg</sub>	Storage temperature		°C
T <sub>j</sub>	Max. operating junction temperature	- 55 to 150	

- 1. Limited by maximum junction temperature
- 2. Pulse width limited by safe operating area.
- 3.  $I_{SD} \leq$  10 A, di/dt  $\leq$  400 A/ $\mu$ s;  $V_{DS peak} < V_{(BR)DSS}$ ,  $V_{DD}$ =400 V.
- $4. \quad V_{DS} \leq 400 \ V$

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	5	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-amb max	62.5	°C/W

Table 4. Avalanche characteristics

Symbol	Parameter	Value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax}$ )	3.5	Α
E <sub>AS</sub>	Single pulse avalanche energy (starting T <sub>j</sub> =25°C, I <sub>D</sub> = I <sub>AR</sub> ; V <sub>DD</sub> =50)	204	mJ

Electrical characteristics STF12N50M2

## 2 Electrical characteristics

(T<sub>C</sub> = 25 °C unless otherwise specified)

Table 5. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	V <sub>GS</sub> = 0, I <sub>D</sub> = 1 mA	500			V
	Zero gate voltage	$V_{GS} = 0, V_{DS} = 500 \text{ V}$			1	μΑ
I <sub>DSS</sub>	drain current	$V_{GS} = 0$ , $V_{DS} = 500 \text{ V}$ , $T_C = 125 \text{ °C}$			100	μΑ
I <sub>GSS</sub>	Gate-body leakage current	$V_{DS} = 0, V_{GS} = \pm 25 \text{ V}$			±10	μΑ
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu\text{A}$	2	3	4	V
R <sub>DS(on)</sub>	Static drain-source on-resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5 A		0.325	0.38	Ω

Table 6. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	560	-	pF
C <sub>oss</sub>	Output capacitance	$V_{GS} = 0, V_{DS} = 100 V,$	-	33	-	pF
C <sub>rss</sub>	Reverse transfer capacitance	f = 1 MHz	-	1	-	pF
C <sub>oss eq.</sub> <sup>(1)</sup>	Equivalent output capacitance	V <sub>GS</sub> = 0, V <sub>DS</sub> = 0 to 400 V	-	125	-	pF
R <sub>G</sub>	Intrinsic gate resistance	f = 1 MHz, I <sub>D</sub> =0	-	6.8	-	Ω
Qg	Total gate charge	V 400 V 1 40 A	-	15	-	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>DD</sub> = 400 V, I <sub>D</sub> = 10 A, V <sub>GS</sub> = 10 V (see <i>Figure 15</i> )	-	3	-	nC
Q <sub>gd</sub>	Gate-drain charge	1GS 10 1 (000 / 194/0 / 10)	-	8.3	-	nC

<sup>1.</sup>  $C_{\rm oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{\rm oss}$  when  $V_{\rm DS}$  increases from 0 to 80%  $V_{\rm DSS}$ 



Table 7. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time		-	13.5	-	ns
t <sub>r</sub>	Rise time	$V_{DD} = 250 \text{ V}, I_D = 5 \text{ A},$	-	10.5	-	ns
t <sub>d(off)</sub>	Turn-off delay time	$R_G = 4.7 \Omega, V_{GS} = 10 V$ (see <i>Figure 14</i> and <i>19</i> )	-	8	-	ns
t <sub>f</sub>	Fall time		-	34.5	-	ns

Table 8. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		-		10	Α
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		40	Α
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage $V_{GS} = 0$ , $I_{SD} = 10$ A		-		1.6	٧
t <sub>rr</sub>	Reverse recovery time	10.4.15/14.400.4/	-	276		ns
$Q_{rr}$	Reverse recovery charge	$I_{SD} = 10 \text{ A, di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 60 \text{ V (see Figure 16)}$	-	2.4		μC
I <sub>RRM</sub>	Reverse recovery current	TDD co ( (coc r igano ro)	-	17.5		Α
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 10 A, di/dt = 100 A/ <i>μ</i> s	-	376		ns
Q <sub>rr</sub>	Reverse recovery charge	V <sub>DD</sub> = 60 V, T <sub>j</sub> =150 °C	-	3.4		μC
I <sub>RRM</sub>	Reverse recovery current	(see Figure 16)	-	18.3		Α

<sup>1.</sup> Pulse width limited by safe operating area

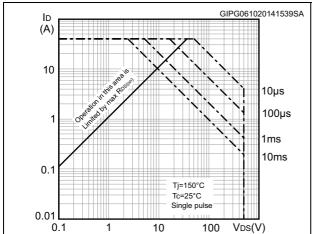
<sup>2.</sup> Pulsed: pulse duration = 300  $\mu$ s, duty cycle 1.5%

**Electrical characteristics STF12N50M2** 

#### **Electrical characteristics (curves)** 2.1

Figure 2. Safe operating area

Figure 3. Thermal impedance



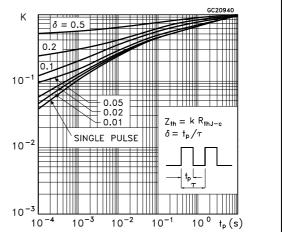
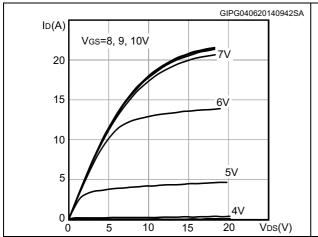


Figure 4. Output characteristics

Figure 5. Transfer characteristics



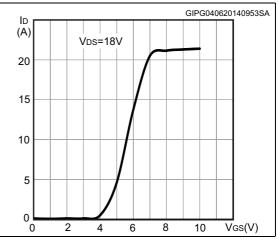
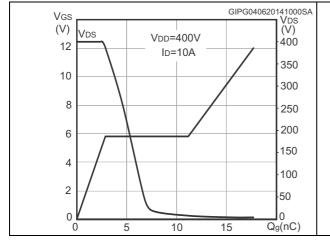


Figure 6. Gate charge vs gate-source voltage

Figure 7. Static drain-source on-resistance



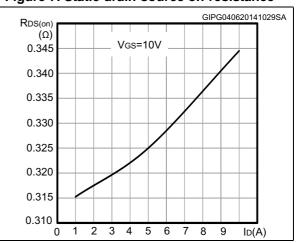


Figure 8. Capacitance variations

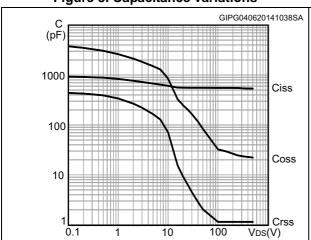


Figure 9. Output capacitance stored energy

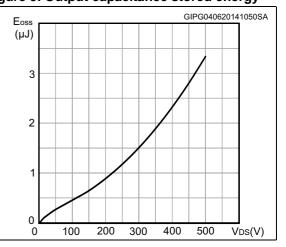
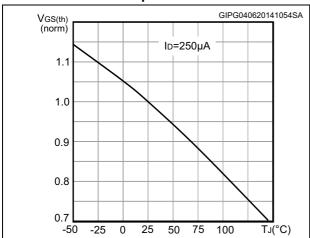


Figure 10. Normalized gate threshold voltage vs temperature

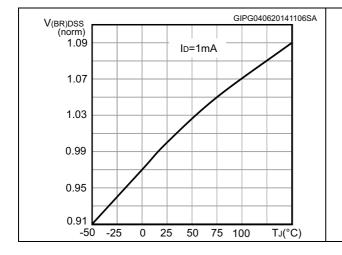
Figure 11. Normalized on-resistance vs temperature

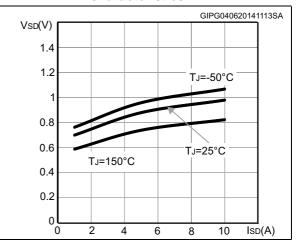


GIPG040620141059SA RDS(on) (norm) Vgs=10V 2.3 2.1 1.9 1.7 1.5 1.3 1.1 0.9 0.7 0.5 -50 -25 0 25 50 75 100 TJ(°C)

Figure 12. Normalized V<sub>(BR)DSS</sub> vs temperature

Figure 13. Source-drain diode forward characteristics





Test circuits STF12N50M2

## 3 Test circuits

Figure 14. Switching times test circuit for resistive load

Figure 15. Gate charge test circuit

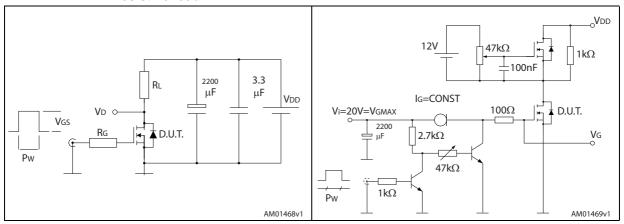


Figure 16. Test circuit for inductive load switching and diode recovery times

Figure 17. Unclamped inductive load test circuit

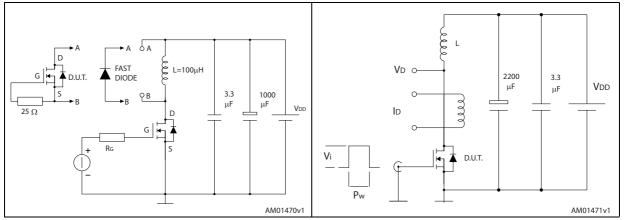
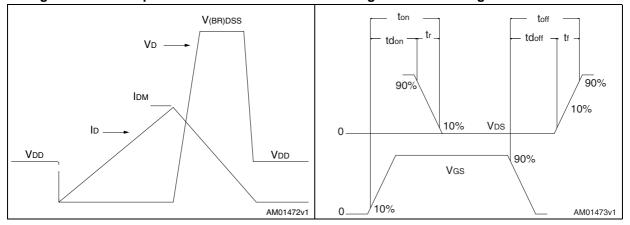


Figure 18. Unclamped inductive waveform

Figure 19. Switching time waveform



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# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.



-*B*-Dia L6 L2 *L7* L3 F1 **L4** F2 Ε -G1-7012510\_Rev\_K\_B

Figure 20. TO-220FP drawing

Table 9. TO-220FP mechanical data

Dim		mm	
Dim.	Min.	Тур.	Max.
Α	4.4		4.6
В	2.5		2.7
D	2.5		2.75
Е	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
Н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Ø	3		3.2



Revision history STF12N50M2

# 5 Revision history

Table 10. Document revision history

Date	Revision	Changes
18-Jun-2014	1	First release.

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